

Search Notes



Application/Control No.

10/823,575

Examiner

Cuong Q. Nguyen

Applicant(s)/Patent under Reexamination

EDAMURA ET AL.

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
257	20-40 78 414-422	3-20-05 	CD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
257	4114	3-20-05	CD
	421	11	11

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EHST+EPD+JPO	3-20-05	CD